

**Search Notes****Application/Control No.**

10/684,771

**Examiner**

Pablo N. Tran

**Applicant(s)/Patent under Reexamination**

SENDONARIS ET AL.

**Art Unit**

2618

**SEARCHED**

Class	Subclass	Date	Examiner
455	255	03/17/07	p2
260			
265			
258			
259			
264			
552.1			
180.3			
87			
141			
182.1			
182.2 - 183.2			
190.1 - 191.1			
192.1 - 192.2			

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Fast / weak	03/17/07	p2

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
455	260	03/17/07	p2
265			
258			
259			

**Search Notes (continued)**

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Art Unit

2618

**SEARCHED**

Class	Subclass	Date	Examiner
455	208-209	03/17/07	PD
	313		
	315		
	318		
378	362		
	372		
	376		
	157		
342	347	↓	↓

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner